

N-channel DFN3333-8 30 V 3.6 mΩ logic level MOSFET Rev. 4 — 12 December 2011 Product da

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel MOSFET in DFN3333-8 package qualified to 150 °C. This product is designed and qualified for use in a wide range of industrial, communications and power supply equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Small footprint for compact designs
- Suitable for logic level gate drive sources

1.3 Applications

- Battery protection
- DC-to-DC converters

- Load switching
- Power ORing

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	30	V
I_D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u>	-	-	40	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	71	W
Tj	junction temperature		-55	-	150	°C
Static cha	racteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 100 ^{\circ}\text{C};$ see <u>Figure 12</u>	-	-	5	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 13</u>	-	4.3	5.6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 13</u>	-	3	3.6	mΩ
Dynamic o	characteristics					
Q_GD	gate-drain charge	V_{GS} = 10 V; I_D = 15 A; V_{DS} = 15 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	5	-	nC



Table 1. Quick reference data ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$Q_{G(tot)} \\$	total gate charge	$V_{GS} = 4.5 \text{ V}$; $I_D = 15 \text{ A}$; $V_{DS} = 15 \text{ V}$; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	18	-	nC
		$V_{GS} = 10 \text{ V}$; $I_D = 15 \text{ A}$; $V_{DS} = 15 \text{ V}$; see Figure 14; see Figure 15	-	37	-	nC
Avalanche	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 40 A; $V_{sup} \le$ 30 V; unclamped; R_{GS} = 50 Ω	-	-	118	mJ

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source	8 7 6 5	D
3	S	source		
4	G	gate		
5,6,7,8	D	drain		mbb076 S
mb	D	mounting base; connected to drain	Transparent top view	
			SOT873-1 (DFN3333-8)	

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PSMN3R5-30LL	DFN3333-8	plastic thermal enhanced very thin small outline package; no leads; 8 terminals	SOT873-1

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	30	V
V_{DGR}	drain-gate voltage	$T_j \le 150 {}^{\circ}\text{C}; T_j \ge 25 {}^{\circ}\text{C}; R_{GS} = 20 k\Omega$	-	30	V
V_{GS}	gate-source voltage		-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 100 °C; see <u>Figure 1</u>	-	40	Α
		V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 1</u>	-	40	А
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$; see Figure 3	-	423	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	71	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
Source-drai	n diode				
Is	source current	T _{mb} = 25 °C	-	40	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	423	Α
Avalanche r	uggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 40 A; $V_{sup} \le$ 30 V; unclamped; R_{GS} = 50 Ω	-	118	mJ

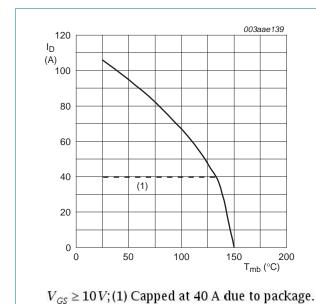
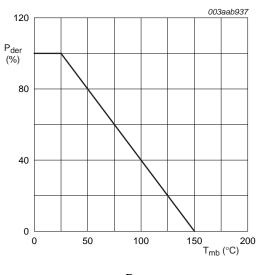
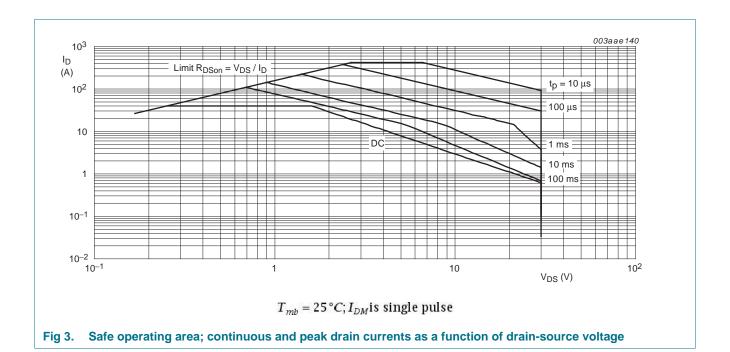


Fig 1. Continuous drain current as a function of mounting base temperature



 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$

Fig 2. Normalized total power dissipation as a function of solder point temperature



5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	1	1.3	K/W
R _{th(j-a)}	thermal resistance from junction to ambient		<u>[1]</u> _	53	60	K/W

[1] $R_{th(j-a)}$ is guaranteed by design and assumes that the device is mounted on a 40mm x 40mm x 70µm copper pad at 20°C ambient temperature. In practice $R_{th(j-a)}$ will be determined by the customer's PCB characteristics

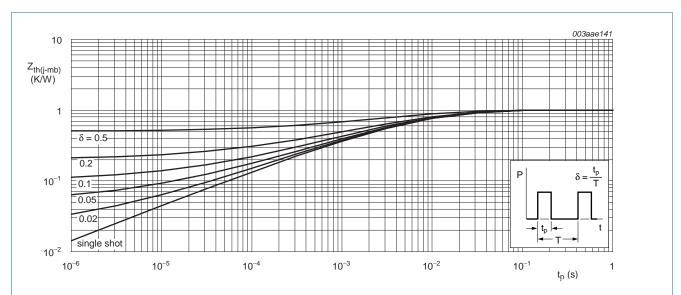


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

6. Characteristics

Table 6 Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 ^{\circ}\text{C}$	27	-	-	V
		$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	30	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 150$ °C; see <u>Figure 10</u>	0.5	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see <u>Figure 11</u> ; see <u>Figure 10</u>	1.3	1.7	2.15	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see <u>Figure 10</u>	-	-	2.6	V
I _{DSS}	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	1	μΑ
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$	-	-	50	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	5	100	nΑ
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	5	100	nΑ
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 100 \text{ °C};$ see <u>Figure 12</u>	-	-	5	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ see Figure 13	-	4.3	5.6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 150 \text{ °C};$ see <u>Figure 12</u>	-	5.4	6.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 13</u>	-	3	3.6	mΩ
R_G	internal gate resistance (AC)	f = 1 MHz	-	2.4	-	Ω
Dynamic	characteristics					
$Q_{G(tot)}$	total gate charge	I_D = 15 A; V_{DS} = 15 V; V_{GS} = 4.5 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	18	-	nC
		I_D = 15 A; V_{DS} = 15 V; V_{GS} = 10 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	37	-	nC
		$I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V$	-	33	-	nC
Q_{GS}	gate-source charge	I_D = 15 A; V_{DS} = 15 V; V_{GS} = 10 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	6	-	nC
Q _{GS(th)}	pre-threshold gate-source charge	$I_D = 15 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 10 \text{ V};$	-	3.4	-	nC
Q _{GS(th-pl)}	post-threshold gate-source charge	see <u>Figure 14</u>	-	2.5	-	nC
Q_{GD}	gate-drain charge	I_D = 15 A; V_{DS} = 15 V; V_{GS} = 10 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	5	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	V _{DS} = 15 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	2.7	-	V
C _{iss}	input capacitance	$V_{DS} = 15 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	2061	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 16</u>	-	409	-	pF
C _{rss}	reverse transfer capacitance		-	177	-	pF

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
O DOI	i didiliotoi	Conditions		יאָרי	mux	0.1110
t _{d(on)}	turn-on delay time	$V_{DS} = 15 \text{ V}; R_L = 1 \Omega; V_{GS} = 4.5 \text{ V};$	-	23	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \Omega; T_j = 25 \text{ °C}$	-	54	-	ns
t _{d(off)}	turn-off delay time		-	35	-	ns
t _f	fall time		-	18	-	ns
Source-dr	ain diode					
V_{SD}	source-drain voltage	$I_S = 10 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 17	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 15 \text{ A}; dI_S/dt = 100 \text{ A/}\mu\text{s};$	-	37	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 15 \text{ V}$	-	34	-	nC

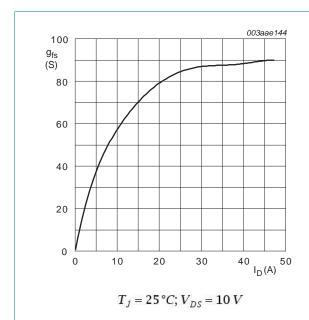


Fig 5. Forward transconductance as a function of drain current; typical values

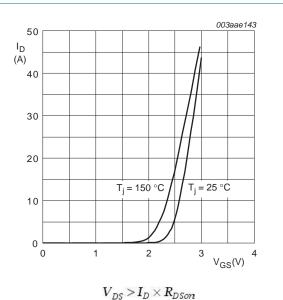


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

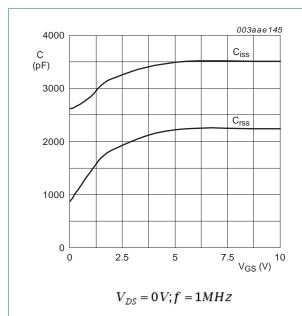


Fig 7. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

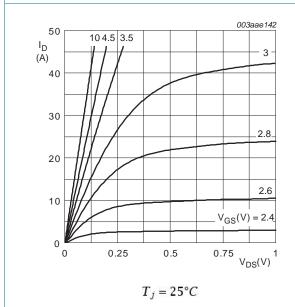


Fig 9. Output characteristics: drain current as a function of drain-source voltage; typical values

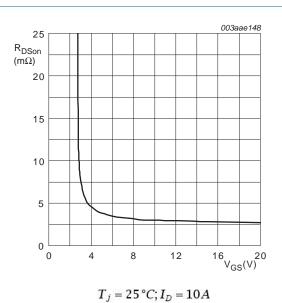


Fig 8. Drain-source on-state resistance as a function of gate-source voltage; typical values

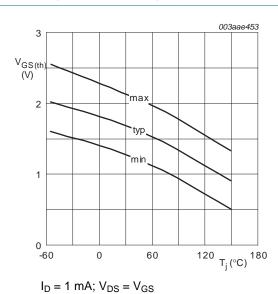


Fig 10. Gate-source threshold voltage as a function of junction temperature

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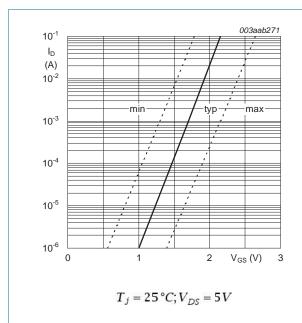


Fig 11. Sub-threshold drain current as a function of gate-source voltage

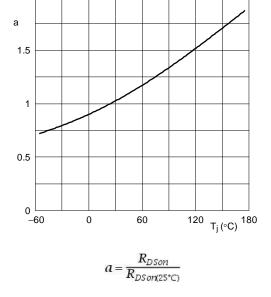


Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature

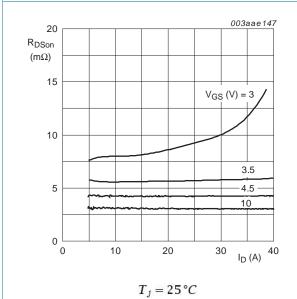


Fig 13. Drain-source on-state resistance as a function of drain current; typical values

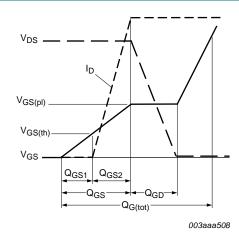


Fig 14. Gate charge waveform definitions

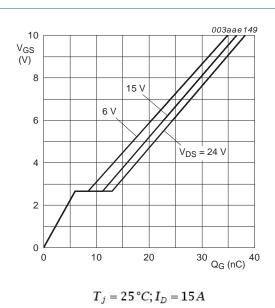
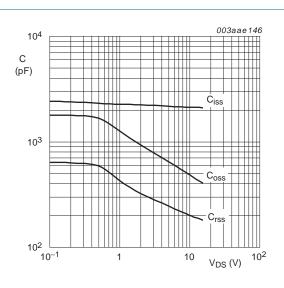


Fig 15. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$

Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

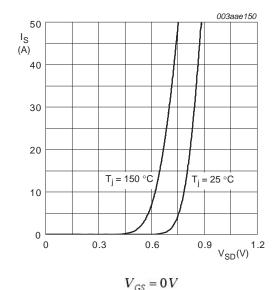


Fig 17. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

7. Package outline

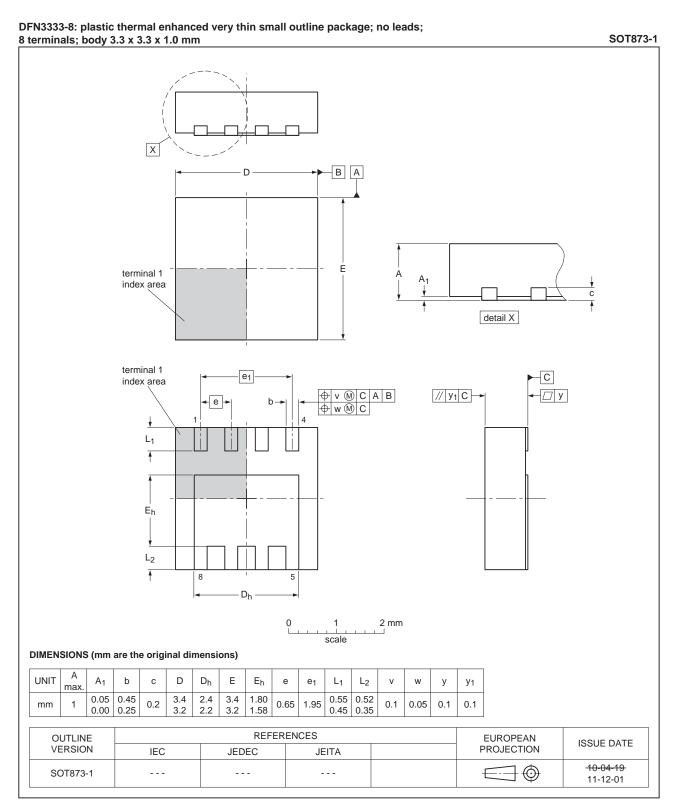


Fig 18. Package outline SOT873-1 (DFN3333-8)

PSMN3R5-30LL

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN3R5-30LL v.4	20111212	Product data sheet	-	PSMN3R5-30LL v.3
Modifications: • Various changes to content.				
PSMN3R5-30LL v.3	20100818	Product data sheet	-	PSMN3R5-30LL v.2

9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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PSMN3R5-30LL

N-channel DFN3333-8 30 V 3.6 mΩ logic level MOSFET

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PSMN3R5-30LL

NXP Semiconductors

N-channel DFN3333-8 30 V 3.6 $m\Omega$ logic level MOSFET

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